

### SiC Power MOSFET N-Channel Enhancement Mode

#### **Features**

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Avalanche Ruggednes

### **Applications**

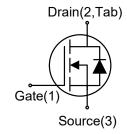
- Solar Inverters
- Switch Mode Power Supplies
- UPS
- Batterry Chargers





## **Package Marking and Ordering Information**

Ordering Part Number	Package	Brand	
IPD65R600C6BTMA1	TO-252-2L	HXY MOSFET	



### **Absolute Maximum Ratings**

Symbol	Parameter	Value	Unit	Test Conditions
$V_{DSmax}$	Drain - Source Voltage	650	V	
$V_{GSmax}$	Gate - Source Voltage (Absolute maximum values)	-8/+22	V	
$V_{GS}$	Gate - Source Voltage	-4/+18	V	
	Continuous Drain Current	6.8	A	T <sub>C</sub> = 25°C
I <sub>D</sub>		4.8		T <sub>C</sub> = 100°C
I <sub>D(pulse)</sub>	Pulsed Drain Current	29	А	Pulse width t <sub>P</sub> limited by T <sub>jmax</sub>
P <sub>TOT</sub>	Power Dissipation	41	W	T <sub>C</sub> = 25°C
$T_{J}$ , $T_{stg}$	Operating Junction and Storage Temperature	-55 to +175	°C	

### $\bullet \mbox{Example}$ of acceptable $V_{\mbox{\scriptsize GS}}$ waveform



# IPD65R600C6BTMA1

## **Electrical Characteristics** (T<sub>C</sub> = 25°C unless other wise specified)

Cumchal	Parameter	Value			11:4	Toot Condition
Symbol		min.	typ.	max.	Unit	Test Condition
Static Cha	aracteristics					
$V_{\text{DSS}}$	Drain-source breakdown voltage	750	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =100uA
V <sub>GS(th)</sub>	Gate threshold voltage	2	2.8	4	V	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =0.43mA
						V <sub>DS</sub> =650V,V <sub>GS</sub> =0V
I <sub>DSS</sub>	Zero gate voltage drain current	-	1	10	μA	T <sub>C</sub> =25°C
		-	5	-		T <sub>C</sub> =175°C
I <sub>GSS</sub>	Gate-source leakage current	-		100	nA	V <sub>GS</sub> =18V,V <sub>DS</sub> =0V
						V <sub>GS</sub> =18V, I <sub>D</sub> =2A,
R <sub>DS(on)</sub>	Drain-source on-state resistance	-	460	610	mΩ	T <sub>J</sub> =25°C
			540			T <sub>J</sub> =175°C
R <sub>DS(on)</sub>	Drain-source on-state resistance	-	580	-	mΩ	V <sub>GS</sub> =15V, I <sub>D</sub> =2A, T <sub>J</sub> =25°C
g <sub>fs</sub>	Transconductance	-	1.3	-	S	V <sub>DS</sub> =20V,I <sub>D</sub> =2A
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	-	176	-		V <sub>DS</sub> = 400V
C <sub>oss</sub>	Output Capacitance	-	17	-	pF	$V_{GS} = 0V$ $T_{J} = 25^{\circ}C$ $V_{AC} = 25mV$ $f = 1MHz$
$C_{rss}$	Reverse Transfer Capacitance	-	2	-	]	
$Q_G$	Gate Total Charge	-	8.5	-		$V_{DS} = 400V$ $V_{GS} = -4/18V$ $I_{D} = 1.6A$
$Q_{gs}$	Gate-Source charge	-	2.6	-	nC	
$Q_{gd}$	Gate-Drain charge	-	2.6	-		
E <sub>ON</sub>	Turn-On Switching Energy	-	32.5	-	1	
E <sub>OFF</sub>	Turn-Off Switching Energy	-	0.53	-	- μJ	V <sub>DD</sub> = 400V
$t_{d(on)}$	Turn-on delay time	-	40	-		$V_{GS} = -4/+18V$ $I_{D} = 1.6A$ $R_{G} = 5\Omega$
t <sub>r</sub>	Rise time	-	33.5	-	] 	
$t_{d(off)}$	Turn-off delay time	-	49	-	ns ns	
t <sub>f</sub>	Fall time	-	54	-		
$R_{G}$	Gate resistance	-	3.7	-	Ω	V <sub>AC</sub> = 25mV, f=1MHz
Body Dio	de Characteristics					•
Van	Rody Diode Forward Voltage		3		- V	V <sub>GS</sub> = 0V,I <sub>SD</sub> =1A, T <sub>J</sub> =25°C
$V_{SD}$	Body Diode Forward Voltage		2.7			V <sub>GS</sub> = 0V,I <sub>SD</sub> =1A, T <sub>J</sub> =175°C
t <sub>rr</sub>	Body Diode Reverse Recovery Time	-	52	-	ns	$V_R = 400V, V_{GS} = 0V$ $I_D = 1.6A$
$Q_{rr}$	Body Diode Reverse Recovery Charge	-	21.8	-	nC	di/dt = 800A/μS Τ <sub>J</sub> = 175°C



### **Thermal Characteristics**

	Symbol	Parameter	Тур.	Unit	Test Conditions
	$R_{thJC}$	Thermal Resistance from Junction to Case	3.7	°C/W	
Ī	$R_{\text{thJA}}$	Thermal Resistance From Junction to Ambient	40	C/VV	

### **Typical Performance**

Fig 1. Output Characteristics (T<sub>J</sub>=-55°C)

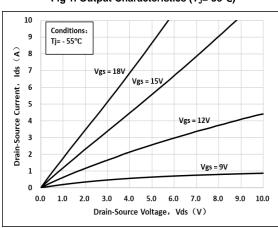


Fig 3. Output Characteristics (T<sub>J</sub>=175℃)

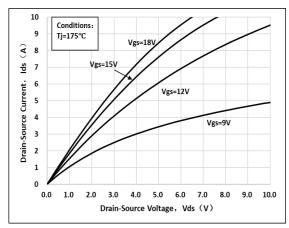


Fig 2. Output Characteristics (T<sub>J</sub>=25℃)

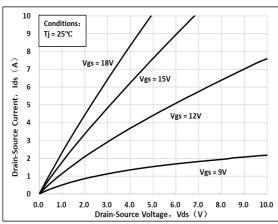


Fig 4: Rdson Vs Ids Characteristics

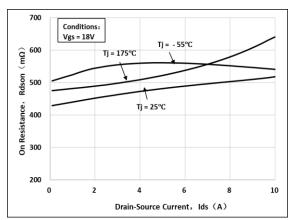


Fig 5: Rds(on) vs. Temperature

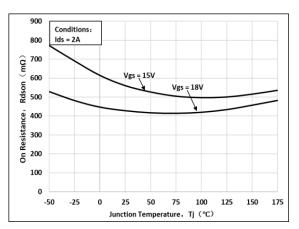


Fig 7: Body-diode Characteristics (TJ=-55°C)

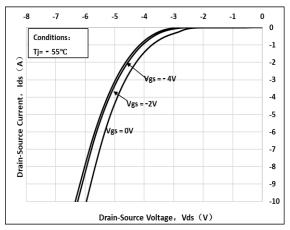


Fig 9: Body-diode Characteristics (T<sub>J</sub>=175°C)

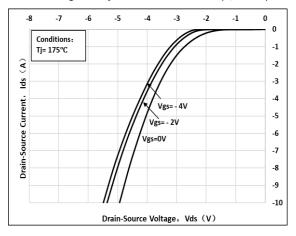


Fig 5: Transfer Characteristics

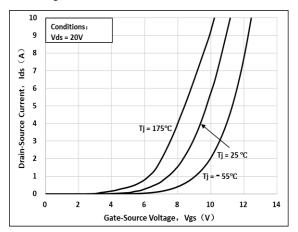


Fig 8: Body-diode Characteristics (TJ=25°C)

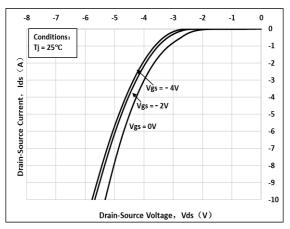


Fig 10: VTH Vs TJ Temperature Characteristics

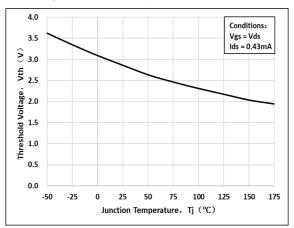


Fig 11: 3rd Quadrant Characteristics(TJ=-55°C)

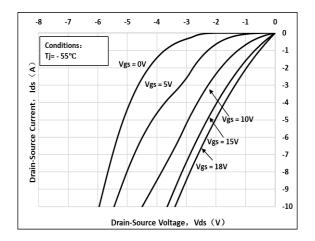


Fig 13: 3rd Quadrant Characteristics(TJ=175°C)

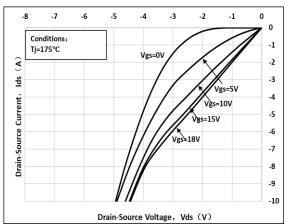


Fig 15:Continuous Drain Current vs.Case Temperature

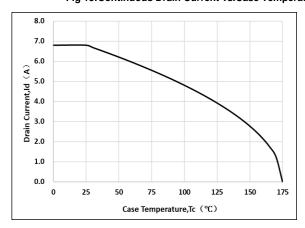


Fig 12: 3rd Quadrant Characteristics(TJ=25°C)

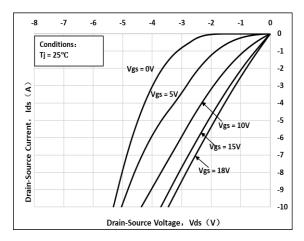


Fig 14: Gate Charge Characteristics

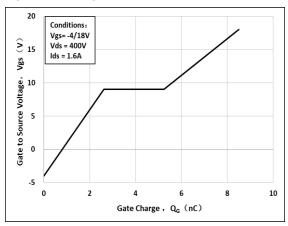


Fig 16: Safe Operating Area

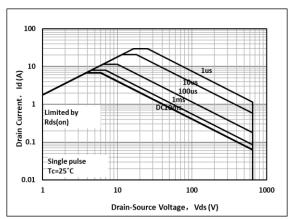


Fig 17: Capacitance Characteristics

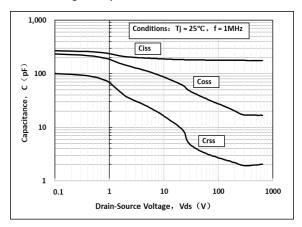
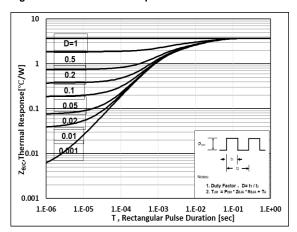


Fig 18: Transient Thermal Impedance



#### **Test Circuit & Waveform**

Figure A. Definition of switching times

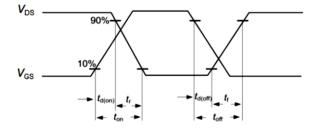


Figure B. Dynamic test circuit

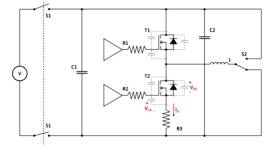


Figure C. Definition of body diodeswitching characteristics

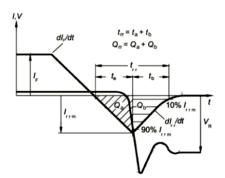
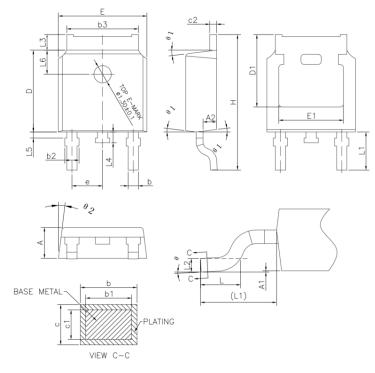


Figure C. Definition of diode switching characteristics



# **Package Dimensions**

Package TO-252-2L



CVMDOL	Unit: mm				
SYMBOL	MIN	NOM	MAX		
Α	2.20	2.30	2.38		
A1	0	-	0.10		
A2	0.90	1.01	1.10		
b	0.72	=	0.85		
b1	0.71	0.76	0.81		
b2	0.72	=	0.90		
b3	5.13	5.33	5.46		
С	0.47	-	0.60		
c1	0.46	0.51	0.56		
c2	0.47	-	0.60		
D	6.00	6.10	6.20		
D1	5.25	-	-		
Е	6.50	6.60	6.70		
E1	4.70	=	-		
е	2.186	2.286	2.386		
Н	9.80	10.10	10.40		
L	1.40	1.50	1.70		
L1	2.90 REF				
L2					
L3	0.90	=	1.25		
L4	0.60	0.80	1.00		
L5	0.15	=	0.75		
L6		1.80 REF			
θ	0°	-	8°		
θ1	5°	7°	9°		
θ2	5°	7°	9°		

## IPD65R600C6BTMA1

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